# **MOSFET** – Power, P-Channel, SOIC-8 -30 V, -11.4 A

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- SOIC-8 Surface Mount Package Saves Board Space
- This is a Pb-Free Device

#### **Applications**

- Load Switches
- Notebook PC's
- Desktop PC's

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Ratir	Rating			Value	Unit
Drain-to-Source Voltage	Drain-to-Source Voltage			-30	V
Gate-to-Source Voltage	Gate-to-Source Voltage		V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	-8.9	Α
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 70°C		-7.1	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	1.52	W
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-6.6	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 70°C		-5.3	
Power Dissipation $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.84	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	-11.4	Α
Current R <sub>θJA</sub> t < 10 s (Note 1)		T <sub>A</sub> = 70°C		-9.3	
Power Dissipation $R_{\theta JA} t < 10 s \text{ (Note 1)}$		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.5	W
Pulsed Drain Current	$T_A = 25^{\circ}C,$ $t_p = 10 \ \mu s$		I <sub>DM</sub>	-46	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	-2.1	Α
Single Pulse Drain-to-Source Avalanche Energy T <sub>J</sub> = 25°C, V <sub>DD</sub> = 30 V, V <sub>GS</sub> = 10 V, I <sub>L</sub> = 20 A <sub>pk</sub> , L = 1.0 mH, R <sub>G</sub> = 25 $\Omega$			EAS	200	mJ
Lead Temperature for So (1/8" from case for 10 s)	oldering P	Lead Temperature for Soldering Purposes			°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface-mounted on FR4 board using 1 inch sq pad size, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

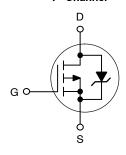


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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max
-30 V	12 mΩ @ –10 V	–11.4 A
-30 V	19 mΩ @ -4.5 V	11.470

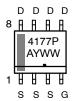
#### P-Channel



#### MARKING DIAGRAM **& PIN ASSIGNMENT**



SOIC-8 **CASE 751** STYLE 12



4177P = Device Code = Assembly Location = Year ww = Work Week

#### ORDERING INFORMATION

= Pb-Free Package

Device	Package	Shipping <sup>†</sup>
NTMS4177PR2G	SOIC-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

Rating	Symbol	Max	Unit	
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	82	°C/W	
Junction-to-Ambient - t≤10 s (Note 3)	$R_{ hetaJA}$	50		
Junction-to-FOOT (Drain)	$R_{\theta JF}$	20		
Junction-to-Ambient - Steady State (Note 4)	$R_{ hetaJA}$	148		

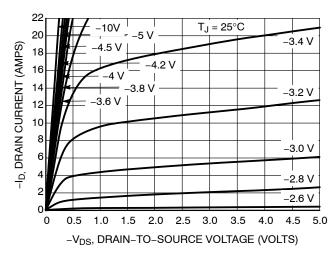
- Surface-mounted on FR4 board using 1 inch sq pad size, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

#### ELECTRICAL CHARACTERISTICS (T = 25°C unless otherwise noted)ik

Characteristic	Symbol	Test Con	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					_	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D$	= -250 μA	-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$				29		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -24 V	$T_{J} = 25^{\circ}C$ $T_{J} = 85^{\circ}C$			-1.0 -5.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>0</sub>				±100	nA
ON CHARACTERISTICS (Note 5)	400	20 7		l	<u>I</u>		1
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub>	_ = -250 นA	-1.5		-2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	GG 1567 15			6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -10 \text{ V}$	$I_D = -11.4 \text{ A}$		10	12	<b>~</b> 0
		$V_{GS} = -4.5 \text{ V}$	I <sub>D</sub> = -9.1 A		15	19	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = −1.5 V	I <sub>D</sub> = -11.4 A		30		S
CHARGES, CAPACITANCES AND GATE F	RESISTANCE						
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -24 \text{ V}$			3100		pF
Output Capacitance	C <sub>OSS</sub>			)	550		
Reverse Transfer Capacitance	C <sub>RSS</sub>				370		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$ $I_{D} = -11.4 \text{ A}$ $V_{GS} = -10 \text{ V}, V_{DS} = -15 \text{ V},$ $I_{D} = -11.4 \text{ A},$			29		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.3		
Gate-to-Source Charge	Q <sub>GS</sub>				10		
Gate-to-Drain Charge	$Q_{GD}$				13		
Total Gate Charge	Q <sub>G(TOT)</sub>				55		nC
Gate Resistance	$R_{G}$				2.0	4.0	Ω
SWITCHING CHARACTERISTICS (Note 6)							
Turn-On Delay Time	t <sub>d(ON)</sub>				18		ns
Rise Time	t <sub>r</sub>	$V_{GS} = -10 \text{ V, V}$ $I_{D} = -1.0 \text{ A, F}$	<sub>DD</sub> = -15 V,		13		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = -1.0 \text{ A}, F$	$R_{G} = 6.0 \Omega$		64		
Fall Time	t <sub>f</sub>				36		
DRAIN-TO-SOURCE CHARACTERISTICS	3						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C		-0.73	-1.0	V
		$I_D = -2.1 \text{ A}$	T <sub>J</sub> = 125°C		0.54		
Reverse Recovery Time	t <sub>RR</sub>				34		<b>1</b>
Charge Time	Ta	$V_{GS} = 0 \text{ V, } d_{IS}/d$	<sub>t</sub> = 100 A/μs,		18		ns
Discharge Time	T <sub>b</sub>	I <sub>S</sub> = -2.1 A			16		
Reverse Recovery Time	$Q_{RR}$				30		nC

- 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 6. Switching characteristics are independent of operating junction temperatures.

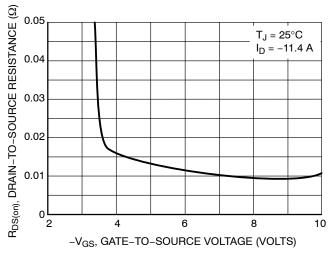
#### **TYPICAL PERFORMANCE CURVES**



 $V_{DS} \ge 10 \text{ V}$ 20 -ID, DRAIN CURRENT (AMPS) 18 16 14 12 10 T<sub>J</sub> = 125°C  $T_J = 25^{\circ}C$ 2  $T_{,l} = -55^{\circ}C$ 0**└** 1.5 2.0 3.0 3.5 4.0 -V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



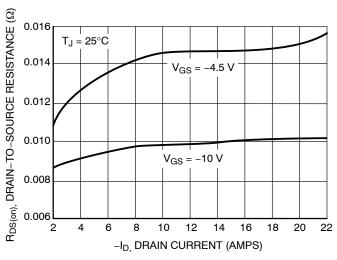
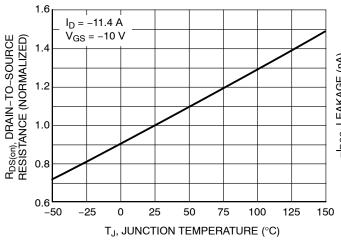


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



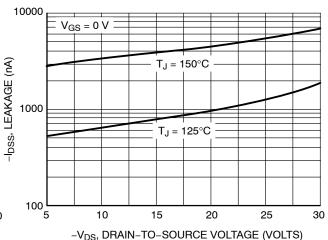


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL PERFORMANCE CURVES**

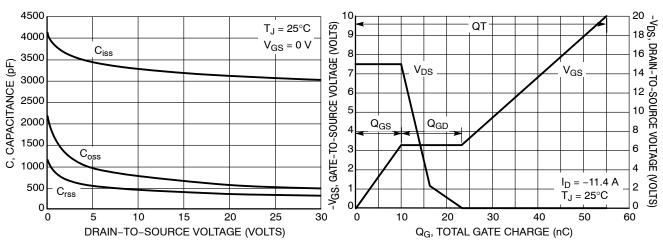


Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

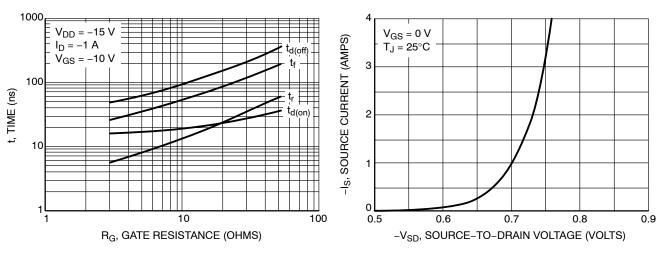


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

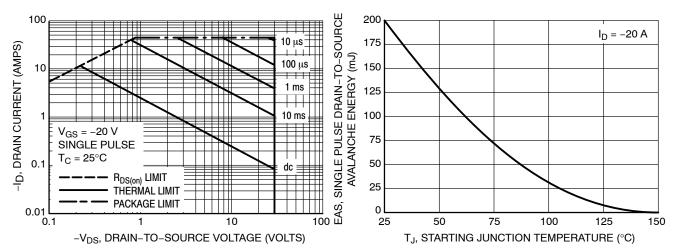


Figure 11. Maximum Rated Forward Biased Safe Operating Area

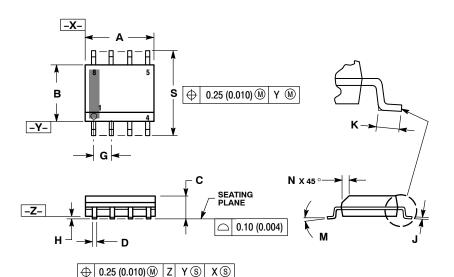
Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature





SOIC-8 NB CASE 751-07 **ISSUE AK** 

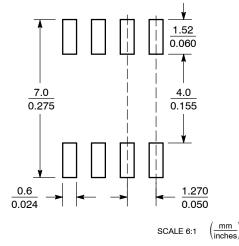
**DATE 16 FEB 2011** 



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

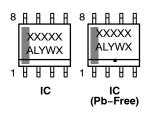
	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	4.00	0.150	0.157	
С	1.35	1.75	0.053	0.069	
D	0.33	0.51	0.013	0.020	
G	1.27	1.27 BSC		0 BSC	
Н	0.10	0.25	0.004	0.010	
J	0.19	0.25	0.007	0.010	
K	0.40	1.27	0.016	0.050	
М	0 °	8 °	0 °	8 °	
N	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0.244	

## **SOLDERING FOOTPRINT\***



<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code = Assembly Location = Wafer Lot

= Year = Work Week W = Pb-Free Package

XXXXXX XXXXXX AYWW AYWW H  $\mathbb{H}$ Discrete **Discrete** (Pb-Free)

XXXXXX = Specific Device Code = Assembly Location Α

ww = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may

not follow the Generic Marking.

#### **STYLES ON PAGE 2**

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#### SOIC-8 NB CASE 751-07 ISSUE AK

#### **DATE 16 FEB 2011**

STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER	STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1	STYLE 4: PIN 1. ANODE 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE
STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE	PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE	PIN 1. INPUT  2. EXTERNAL BYPASS  3. THIRD STAGE SOURCE  4. GROUND  5. DRAIN  6. GATE 3  7. SECOND STAGE Vd  8. FIRST STAGE Vd	PIN 1. COLLECTOR, DIE #1 2. BASE, #1
STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON	STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND	STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN	STYLE 14:  PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC	STYLE 18: PIN 1. ANODE 2. ANODE	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN
3. V10UT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC  STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6	STYLE 22:	7. DRAIN 1 8. MIRROR 1 STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT	STYLE 24: PIN 1. BASE 2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE
STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT	STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN
STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1	STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		

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